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Effect of the measurement errors on two one-sided Shewhart control charts for monitoring the ratio of two normal variables

Huu Du Nguyen¹ and Kim Phuc Tran^{*2}

¹Institute of Artificial Intelligence and Data Science, Dong A University, Danang, Vietnam

²Ecole Nationale Supérieure des Arts et Industries Textiles, GEMTEX Laboratory, BP 30329 59056 Roubaix Cedex 1, France,

^{*}Corresponding author. Email: kim-phuc.tran@ensait.fr

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Abstract

Monitoring the ratio between two random normal variables plays an important role in many industrial manufacturing processes. In this paper, we suggest designing two one-sided Shewhart control charts monitoring this ratio. The numerical results show that the one-sided charts have more advantages compared to the two-sided Shewhart chart proposed previously in the literature. Moreover, we investigate the effect of measurement error on the performance of these control charts where the measurement error is supposed to follow a linear covariate error model. The change of model parameters from an in-control condition to an out-of-control is presented without using a strict assumption about the independence of the shift size from measurement errors. A valuable finding from this study is that taking multiple measurements per item is not an effective way to reduce the negative effect of measurement error on the Shewhart charts' performance.

Keyword Shewhart control chart, Ratio distribution, Measurement error, One-sided chart, Linear covariate error.

1 Introduction

Designing a new control chart with higher performance in detecting shifts is a vital aim in many studies in Statistical Process Control (SPC), see, for example, Ren et al.¹, Mukherjee and Rakitzis², Ho et al.³, and Nguyen et al.⁴. However, a requirement of being easy and convenient to implement also

plays an equally important role in deciding what kind of control chart to use. As a result, the Shewhart control chart introduced by Shewhart⁵ since 1931 is widely used in many industrial processes. Although the performance of the Shewhart chart in detecting small and moderate shifts is not as good as the one of the other advanced charts like the CUSUM control chart (Brook and Evans⁶) and the EWMA control chart (Hunter⁷), this kind of control chart has a major advantage of being easy to implement. Moreover, the Shewhart chart is well-known to be effective in detecting large process shifts. Consequently, it is usually considered first to monitor a process.

The ratio of two normal variables is a major concern in several industrial manufacturing processes. Several applications of this characteristic in practice have been pointed out in the literature. Tran et al.⁸ provided a real example in some battery recycling plants in Italy where the requirement of monitoring the ratio of “recyclable batteries” weight and “total batch” weight to quantify the economic loss is needed. Celano and Castagliola⁹ discussed another example in the food industry where the weight ratio between “pumpkin seeds” and “flaxseeds” is the characteristic of interest. Typical examples of the manufacturing environments that concern the ratio of two variables were mentioned in Tran et al.^{10,11}.

In order to enhance the practical use of the ratio chart, the effect of measurement error has been considered in recent times. In fact, the problem of measurement error has been investigated broadly in the literature, for example, Linna et al.¹², Tang et al.¹³, Tran et al.^{14,15,16,17}, Cheng and Wang¹⁸, Sabahno et al.¹⁹, Nguyen et al.²⁰, and Zaidi et al.²¹. For the case of the ratio control charts, Tran et al.⁸ was the first to study the effect of measurement error on a ratio Shewhart chart. However, in this study, the authors used a relatively tight assumption about the observed value of process shifts. That is, the observed process shift is independent from measurement error. In this study, we would like to reduce this assumption to make the study more practical. We use the same kind of control chart, which is the Shewhart chart, to monitor the ratio under the presence of measurement error. The effect of measurement error on the Shewhart ratio control chart will be explored without using this assumption. The change of parameters of the process in the presence of the measurement error will be discussed in detail.

Another problem that should be paid attention to in designing a control chart monitoring the ratio is the asymmetry of the ratio distribution. The distribution of a characteristic of interest is a deciding factor that influences the design of a control chart. For an asymmetric distribution, using a two-sided control chart to monitor both an increase and a decrease of the characteristic may lead to an *ARL*-biased (average run length) property in the sense that the out-of-control *ARL* values are sometimes larger than the in-control value. This issue has been mentioned in several studies such as Nguyen et al.^{22,23,24}, and Nguyen et al.²⁵. The two-sided Shewhart control

chart monitoring the ratio (say, the Shewhart-RZ control chart) suggested by Celano and Castagliola⁹ is also not an exception. An example of the *ARL*-biased situation witnessed in Celano and Castagliola⁹ will be illustrated in section 4 of this paper. Therefore, in this study, we suggest designing two one-sided Shewhart control charts to monitor separately an increase and a decrease in the ratio. The goal of this paper is then to investigate the performance of these one-sided control charts with or without the presence of measurement error. Under an assumption of no measurement error, the simulated results show that the one-sided Shewhart-RZ control charts perform better the two-sided Shewhart-RZ chart both in avoiding the *ARL*-biased problem and in detecting ratio shifts. Under the presence of measurement error, the effect of each parameter in the linear covariate error model on the charts' performance will be studied.

The rest of the paper is organized as follows. In section 2, we present briefly a review of the sample distribution of the ratio between two normal variables. Section 3 is to present the design and the implementation of the two-sided Shewhart-RZ control charts. The performance of these control charts in the case of no measurement error is given in section 4. Section 5 demonstrates a linear covariate error model for the ratio and an establishment of the change in the model parameters from an in-control condition to an out-of-control one. The implementation and the design of the two-sided Shewhart-RZ control charts in the presence of measurement error are discussed in section 6 while the effect of measurement error on the performance of these charts is presented in section 7. An illustrative example of the implementation of a two-sided Shewhart-RZ control chart under the appearance of measurement error is given in section 8. Section 9 is for some concluding remarks.

2 A brief review of the sample distribution the ratio

Consider a bivariate normal random vector $\mathbf{W} = (X, Y)^T$ with the mean vector $\boldsymbol{\mu}_W$ and the variance-covariance matrix $\boldsymbol{\Sigma}_W$ defined by

$$\boldsymbol{\mu}_W = \begin{pmatrix} \mu_X \\ \mu_Y \end{pmatrix} \quad \text{and} \quad \boldsymbol{\Sigma}_W = \begin{pmatrix} \sigma_X^2 & \rho\sigma_X\sigma_Y \\ \rho\sigma_X\sigma_Y & \sigma_Y^2 \end{pmatrix}, \quad (1)$$

where ρ is the correlation coefficient between X and Y ; σ_X and σ_Y are the standard deviation of X and Y . Let μ_X and μ_Y denote their mean. Then the coefficients of variations and the standard-deviation ratio of X and Y are $\gamma_X = \frac{\sigma_X}{\mu_X}$, $\gamma_Y = \frac{\sigma_Y}{\mu_Y}$ and $\omega = \frac{\sigma_X}{\sigma_Y}$, respectively.

The ratio of X to Y is defined as $Z = X/Y$. A number of studies on the distribution of Z can be found in the literature, see, for example, Geary²⁶, Hayya et al.²⁷, Pham-Gia et al.²⁸. Cedilnik et al.²⁹ proposed

a general explicit expression for the probability density function (*p.d.f*) of Z while its cumulative distribution function (*c.d.f*) and its inverse *c.d.f* could be computed numerically as proposed in Celano et al.³⁰. However, these methods are relatively complicated to be implemented. Therefore, the approximated distributions are often preferable. According to Celano and Castagliola⁹, when the coefficient of variation of X and Y is not large, the distribution of Z can be well approximated by

$$F_Z(z|\gamma_X, \gamma_Y, \omega, \rho) \simeq \Phi\left(\frac{A}{B}\right), \quad (2)$$

where $\Phi(\cdot)$ is the *c.d.f* of the standard normal distribution, and where A and B are functions of z , γ_X , γ_Y , ω and ρ with

$$\begin{aligned} A &= \frac{z}{\gamma_Y} - \frac{\omega}{\gamma_X}, \\ B &= \sqrt{\omega^2 - 2\rho\omega z + z^2}. \end{aligned}$$

To be sure of the stability of a processes with normally distributed quality parameters, the population dispersion should be significantly smaller than the mean. Thus, the assumption about small values of γ_X , γ_Y and then the approximated distribution is reasonable. Based on the *c.d.f* in (2), it is easy to show that the *p.d.f* of Z is

$$f_Z(z|\gamma_X, \gamma_Y, \omega, \rho) \simeq \left(\frac{1}{B\gamma_Y} - \frac{(z - \rho\omega)A}{B^3} \right) \times \phi\left(\frac{A}{B}\right), \quad (3)$$

where $\phi(\cdot)$ is the *p.d.f* of the standard normal distribution. Some pictures of the *p.d.f* of Z for the case $\rho = 0.4$, $\omega = 0.9\gamma_X/\gamma_Y$ and different values of γ_X and γ_Y are drawn in Figure 1.

In the same way, an approximation for the *i.d.f* (inverse distribution function) $F_Z^{-1}(p|\gamma_X, \gamma_Y, \omega, \rho)$ of Z is given by

$$F_Z^{-1}(p|\gamma_X, \gamma_Y, \omega, \rho) \simeq \begin{cases} \frac{-C_2 - \sqrt{C_2^2 - 4C_1C_3}}{2C_1} & \text{if } p \in (0, 0.5], \\ \frac{-C_2 + \sqrt{C_2^2 - 4C_1C_3}}{2C_1} & \text{if } p \in [0.5, 1), \end{cases} \quad (4)$$

where C_1 , C_2 and C_3 are functions of p , γ_X , γ_Y , ω and ρ , i.e.

$$\begin{aligned} C_1 &= \frac{1}{\gamma_Y^2} - \Phi^{-1}(p)^2, \\ C_2 &= 2\omega \left(\rho\Phi^{-1}(p)^2 - \frac{1}{\gamma_X\gamma_Y} \right), \\ C_3 &= \omega^2 \left(\frac{1}{\gamma_X^2} - \Phi^{-1}(p)^2 \right), \end{aligned}$$

and where $\Phi^{-1}(\cdot)$ is the *i.d.f* of the standard normal distribution.

Figure 1: The probability density function of Z for the case $\rho = 0.4$, $\omega = 0.9\gamma_X/\gamma_Y$ and different values of γ_X , γ_Y .

3 Implementation of the one-sided Shewhart-RZ control charts

In order to monitor the ratio Z , a set of n samples of quality characteristic $\mathbf{W}$ at each sampling period, say $\{\mathbf{W}_{i,1}, \mathbf{W}_{i,2}, \dots, \mathbf{W}_{i,n}\}$, is collected. Suppose that $\mathbf{W}_{i,2} = (X_{i,j}, Y_{i,j})^T$ is a bivariate normal vector with mean vector

$$\boldsymbol{\mu}_{\mathbf{W},i} = \begin{pmatrix} \mu_{X,i} \\ \mu_{Y,i} \end{pmatrix} \quad (5)$$

and covariance matrix

$$\boldsymbol{\Sigma}_{\mathbf{W},i} = \begin{pmatrix} \sigma_{X,i}^2 & \rho\sigma_{X,i}\sigma_{Y,i} \\ \rho\sigma_{X,i}\sigma_{Y,i} & \sigma_{Y,i}^2 \end{pmatrix} \quad (6)$$

Similar to Celano and Castagliola⁹, the following assumptions are supposed:

- (i) There is a linear relationship between the mean and the standard deviation of X and Y . That is, we have $\sigma_{X,i} = \gamma_X \times \mu_{X,i}$ and $\sigma_{Y,i} = \gamma_Y \times \mu_{Y,i}$ for every i . Since many quality characteristics have a dispersion proportional to the population mean, it is practical to use a known and constant coefficient of variation of both X and Y .

- (ii) when the process is in-control, the ratio $\frac{\mu_{X,i}}{\mu_{Y,i}}$ is equal to z_0 for every samples. This is an expected value to ensure the stability of the process.
- (iii) the sample units are allowed to change from sample to sample, i.e. it is possible that $\mu_{\mathbf{W},i} \neq \mu_{\mathbf{W},k}$ and $\Sigma_{\mathbf{W},i} \neq \Sigma_{\mathbf{W},k}$ for $i \neq k$.

Then, the monitored statistic is

$$\hat{Z}_i = \frac{\hat{\mu}_{X,i}}{\hat{\mu}_{Y,i}} = \frac{\bar{X}_i}{\bar{Y}_i} = \frac{\sum_{j=1}^n X_{i,j}}{\sum_{j=1}^n Y_{i,j}}, i = 1, 2, \dots \quad (7)$$

In order to determine the distribution of $\hat{Z}_i$, we firstly consider that $\bar{X}_i \sim N(\mu_{X,i}, \frac{\sigma_{X,i}}{\sqrt{n}})$ and $\bar{Y}_i \sim N(\mu_{Y,i}, \frac{\sigma_{Y,i}}{\sqrt{n}})$. Then, the coefficients of variation of $\bar{X}_i$ and $\bar{Y}_i$ are

$$\gamma_{\bar{X}} = \frac{\mu_{X,i}}{\sigma_{X,i}\sqrt{n}} = \frac{\gamma_X}{\sqrt{n}}, \quad (8)$$

$$\gamma_{\bar{Y}} = \frac{\mu_{Y,i}}{\sigma_{Y,i}\sqrt{n}} = \frac{\gamma_Y}{\sqrt{n}}. \quad (9)$$

Similarly, the standard-deviations ratio ω_i at each sampling period i is

$$\omega_i = \frac{\sigma_{X,i}}{\sigma_{Y,i}} = \frac{\mu_{X,i}}{\mu_{Y,i}} \frac{\gamma_X}{\gamma_Y} = z_0 \times \frac{\gamma_X}{\gamma_Y} = \omega_0 \quad \forall i = 1, 2, \dots, \quad (10)$$

where ω_0 is the in-control standard-deviation ratio. The *c.d.f* and the *i.d.f* of $\hat{Z}_i$ now can be written as

$$F_{\hat{Z}_i}(z | n, \gamma_X, \gamma_Y, z_0, \rho_0) = F_Z(z | n, \frac{\gamma_X}{\sqrt{n}}, \frac{\gamma_Y}{\sqrt{n}}, \frac{z_0\gamma_X}{\gamma_Y}, \rho_0) \quad (11)$$

$$F_{\hat{Z}_i}^{-1}(p | n, \gamma_X, \gamma_Y, z_0, \rho_0) = F_Z^{-1}(p | n, \frac{\gamma_X}{\sqrt{n}}, \frac{\gamma_Y}{\sqrt{n}}, \frac{z_0\gamma_X}{\gamma_Y}, \rho_0), \quad (12)$$

with $F_Z(\dots)$ and $F_Z^{-1}(\dots)$ defined in (2) and (4).

It can be seen from the distributions in (2)-(3) (and also the Figure 1) that the distribution of Z is skewed. Therefore, using a single two-sided chart to monitor both an increase and a decrease in the ratio Z will lead to a *ARL*-biased chart as in Celano and Castagliola⁹. We overcome this problem by designing two one-sided charts monitoring the increase or the decrease of the ratio separately. Other advantages of using two one-sided charts to monitor a variable with an asymmetry distribution are further discussed in Nguyen et al.²⁰. In particular, the two one-sided control charts consist of an upper-sided chart, which aims at detecting an increase in the ratio (denoted as ~~Shewhart-RZ⁺~~ chart in the remainder of the paper), and a lower-sided chart, which aims at detecting a decrease in the ratio (denoted as Shewhart-RZ⁻ chart in the remainder of the paper).

Given an in-control average run length ARL_0 , the lower control limit LCL^- of the Shewhart-RZ⁻ chart is defined such that the type I error rate is equal to α_0 where $ARL_0 = 1/\alpha_0$. Thus, the LCL^- is equal to

$$LCL^- = F_Z^{-1} \left(\alpha_0 \mid \frac{\gamma_X}{\sqrt{n}}, \frac{\gamma_Y}{\sqrt{n}}, \frac{z_0 \gamma_X}{\gamma_Y}, \rho_0 \right). \quad (13)$$

The corresponding upper control limit UCL^- of the Shewhart-RZ⁻ chart is $UCL^- = +\infty$.

Similarly, for the upward CV chart, the upper control limit UCL^+ is defined such that the type I error rate is equal to α_0 . That means the UCL is equal to

$$UCL^+ = F_Z^{-1} \left(1 - \alpha_0 \mid \frac{\gamma_X}{\sqrt{n}}, \frac{\gamma_Y}{\sqrt{n}}, \frac{z_0 \gamma_X}{\gamma_Y}, \rho_0 \right), \quad (14)$$

The corresponding upper control limit LCL^+ of the Shewhart-RZ⁻ chart is $LCL^+ = -\infty$.

In the implementation of these two control charts, when $\hat{Z} < LCL^-$ in the Shewhart-RZ⁻ chart or when $\hat{Z} > UCL^+$ in the Shewhart-RZ⁺ chart, the process is considered as out-of-control, and the assignable causes should be investigated and removed. Otherwise, the process is believed to be still in-control.

Now, let us assume that the in-control ratio z_0 is shifted to $z_1 = \tau \times z_0$, where $\tau > 0$ is the shift size, and the in-control coefficient of correlation $\rho = \rho_0$ is shifted to $\rho = \rho_1$ because of an out-of-control condition. For the Shewhart type chart, the out-of-control average run length ARL_1 is calculated by

$$ARL = \frac{1}{p} \quad (15)$$

where p is the probability of detecting a shift. In our case, the probability p is defined as:

- for the Shewhart-RZ⁻ control chart,

$$\begin{aligned} p &= Pr(\hat{Z}_i < LCL^-) \\ &= F_{\hat{Z}} \left(LCL^- \mid \frac{\gamma_X}{\sqrt{n}}, \frac{\gamma_Y}{\sqrt{n}}, \frac{z_0 \gamma_X}{\gamma_Y}, \rho_0 \right), \end{aligned} \quad (16)$$

- for the Shewhart-RZ⁺ control chart,

$$\begin{aligned} p &= Pr(\hat{Z}_i < UCL^+) \\ &= 1 - F_{\hat{Z}} \left(UCL^+ \mid \frac{\gamma_X}{\sqrt{n}}, \frac{\gamma_Y}{\sqrt{n}}, \frac{z_0 \gamma_X}{\gamma_Y}, \rho_0 \right). \end{aligned} \quad (17)$$

4 Performance of the one-sided Shewhart-RZ control charts without the presence of measurement errors

In this section, we investigate the performance of the one-sided Shewhart-RZ control charts based on an assumption that there is no measurement error. For purpose of comparison, we consider the following values of the process parameters, which are exactly the same those considered in⁹:

- $\gamma_X \in \{0.01, 0.2\}$, $\gamma_Y \in \{0.01, 0.2\}$.
- $n \in \{1, 5, 7, 10, 15\}$.
- $\rho_0 \in \{-0.8, -0.4, 0, 0.4, 0.8\}$.
- $\tau \in \{0.9, 0.95, 0.98, 0.99\}$ for the Shewhart-RZ⁻ chart and $\tau \in \{1.01, 1.02, 1.05, 1.0\}$ for the Shewhart-RZ⁺ chart.

Also, the in-control ARL is set at $ARL_0 = 200$ and the in-control ratio is $z_0 = 1$. The control limits of the one-sided Shewhart-RZ control charts for these parameters are presented in Table 1 (column titled “Without measurement error”). The out-of-control ARL , say ARL_1 , for different values of the shift size τ corresponding to these control limits are given in Table 2 (for $\gamma_X = \gamma_Y$, $\rho_0 = \rho_1$), Table 3 (for $\gamma_X \neq \gamma_Y$, $\rho_0 = \rho_1$), Table 4 (for $\gamma_X = \gamma_Y$, $\rho_0 \neq \rho_1$) and Table 5 (for $\gamma_X \neq \gamma_Y$, $\rho_0 \neq \rho_1$). Some simple conclusions can be drawn from these tables as follows.

- In general, the control limits of the one-sided Shewhart-RZ control charts show the same behavior as those of the two-sided Shewhart-RZ control chart. Given (γ_X, γ_Y) , the values of LCL^- and UCL^+ change with n and ρ_0 ; and given the value of n and ρ_0 , the values of LCL^- and UCL^+ change with (γ_X, γ_Y) . Moreover, the relation $LCL^- = 1/UCL^+$ still holds only for the case $\gamma_X = \gamma_Y$. For instance, with $\gamma_X = \gamma_Y = 0.01$, $\rho_0 = 0.0$, $n = 5$, we have $LCL^- = 0.9838 = 1/1.1064 = 1/UCL^+$ (Table 1).
- The one-sided Shewhart-RZ control charts overcome the ARL -biased problem. This is shown by the values less than $ARL_0 = 200$ of the ARL_1 in the one-sided Shewhart-RZ control chart. For example, when $\gamma_X = 0.2$, $\gamma_Y = 0.01$, $n = 1$, $\rho_1 = \rho_0 = -0.4$ and $\tau = 0.99$, we have $ARL_1 = 186.5$ for the one-sided Shewhart-RZ chart (Table 3 in this study) while $ARL_1 = 215.3 > 200$ for the two-sided Shewhart-RZ chart (Table 3 in Celano and Castagliola⁹).
- Besides overcoming the ARL -biased problem, the one-sided Shewhart-RZ control charts also outperform the two-sided chart in detecting the

process shift. For example, with $\gamma_X = \gamma_Y = 0.2$, $\rho_0 = \rho_1 = 0.8$, $n = 5$ and $\tau = 1.05$, we have $ARL_1 = 25.5$ in the Shewhart-RZ⁺ chart and $ARL_1 = 43.9$ in the two-sided Shewhart-RZ chart (Table 2).

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5 Linear covariate error model for the sample of the ratio

In this section, we present a linear covariate error model for the sample ratio. The change of parameters of a process after being shifted under the presence of measurement error will be modeled accurately.

Consider again the bivariate normal random vector $\mathbf{W} \sim N(\boldsymbol{\mu}_{\mathbf{W}}, \boldsymbol{\Sigma}_{\mathbf{W}})$ with the mean $\boldsymbol{\mu}_{\mathbf{W}}$ and the variance-covariance matrix $\boldsymbol{\Sigma}_{\mathbf{W}}$ defined in (1). Let $\{\mathbf{W}_{i,1}, \mathbf{W}_{i,2}, \dots, \mathbf{W}_{i,n}\}$ be a set of n independent samples from this random vector where $\mathbf{W}_{i,j} = (X_{i,j}, Y_{i,j})^T$ represents the quality characteristic of the j^{th} sample, $j = 1, \dots, n$ at the time $i, i = 1, 2, \dots$

The measurement error means that the *true* quality characteristics $\mathbf{W}_{i,j}$ is unobservable. Instead, only a set of a multiple measurement from the j^{th} item at the the time i , say $\{\mathbf{W}_{i,j,1}^*, \mathbf{W}_{i,j,2}^*, \dots, \mathbf{W}_{i,j,m}^*\}, m \geq 1$, is observable. The linear covariate error model (Linna and Woodall³¹) says that these observations are related to the true value $\mathbf{W}_{i,j}$ by the following formula

$$\mathbf{W}_{i,j,k}^* = \mathbf{A} + \mathbf{B}\mathbf{W}_{i,j} + \boldsymbol{\epsilon}_{i,j,k}, k = 1, \dots, m, \quad (18)$$

where $\mathbf{A} = (a_X, a_Y)^T$ is a (2×1) constant vector, $\mathbf{B}$ is a (2×2) matrix, $\boldsymbol{\epsilon} \sim N(\mathbf{0}, \boldsymbol{\Sigma}_M)$ is a bivariate normal random vector independent of $\mathbf{W}$. Let σ_{MX} , σ_{MY} , and $\rho_M \in (-1, +1)$ be the standard-deviation of measurement error of X , Y , and the corresponding coefficient of correlation. Then, the variance-covariance matrix $\boldsymbol{\Sigma}_M$ of $\boldsymbol{\epsilon}$ is denoted by

$$\boldsymbol{\Sigma}_M = \begin{pmatrix} \sigma_{MX}^2 & \rho_M \sigma_{MX} \sigma_{MY} \\ \rho_M \sigma_{MX} \sigma_{MY} & \sigma_{MY}^2 \end{pmatrix}, \quad (19)$$

As in Tran et al.⁸, we consider the case $\mathbf{B} = \mathbf{I}_{2 \times 2}$, an identity matrix. That is a constant vector of accuracy error $\mathbf{A}$ within the range of measurements is assumed.

Since the true value of $\mathbf{W}_{i,j}$ is not observed, the mean

$$\overline{\mathbf{W}}_{i,j}^* = \frac{1}{m} \sum_{k=1}^m \mathbf{W}_{i,j,k}^* = \mathbf{A} + \mathbf{B}\mathbf{W}_{i,j} + \frac{1}{m} \sum_{k=1}^m \boldsymbol{\varepsilon}_{i,j,k} \quad (20)$$

is often considered as its representation. $\overline{\mathbf{W}}_{i,j}^* = (\bar{X}_{i,j}^*, \bar{Y}_{i,j}^*)$ of the observable quantities $\{\mathbf{W}_{i,j,1}^*, \mathbf{W}_{i,j,2}^*, \dots, \mathbf{W}_{i,j,m}^*\}$ is often considered as a represented value for the true value $\mathbf{W}_{i,j}$. Formula (20) shows that $\overline{\mathbf{W}}_{i,j}^*$ is also a bivariate normal random vector with the mean vector

$$\boldsymbol{\mu}_{\mathbf{W}^*} = \mathbf{A} + \mathbf{B}\boldsymbol{\mu}_{\mathbf{W}} \quad (21)$$

and the variance-covariance matrix

$$\boldsymbol{\Sigma}_{\mathbf{W}^*} = \mathbf{B}\boldsymbol{\Sigma}_{\mathbf{W}}\mathbf{B}^T + \boldsymbol{\Sigma}_M = \boldsymbol{\Sigma}_{\mathbf{W}} + \frac{1}{m}\boldsymbol{\Sigma}_M. \quad (22)$$

Based on these general formulas, in the sequel we will study the change of the process parameters under the measurement error when the process is shifted.

When the process is in-control, we denote the mean vector of the true value $\mathbf{W}_{i,j} = (X_{i,j}, Y_{i,j})$ as $\boldsymbol{\mu}_{0,\mathbf{W}} = (\mu_{0,X}, \mu_{0,Y})^T$ and the coefficient of correlation between $X_{i,j}$ and $Y_{i,j}$ as $\rho = \rho_0$. As a result, the mean ratio is $z_0 = \frac{\mu_{0,X}}{\mu_{0,Y}}$. Under an abnormal condition, suppose that the in-control ratio z_0 is shifted to $z_1 = \tau z_0$, where τ is the shift size, and the in-control coefficient of correlation $\rho = \rho_0$ is shifted to $\rho = \rho_1$. The shift of z_0 can be expressed by the shift of $\boldsymbol{\mu}_{\mathbf{W}}$ from the in-control value $\boldsymbol{\mu}_{0,\mathbf{W}}$ to the out-of-control value $\boldsymbol{\mu}_{1,\mathbf{W}} = (\mu_{0,X} + \delta_X \sigma_X, \mu_{0,Y} + \delta_Y \sigma_Y)^T$, where δ_X and δ_Y represent the size of the mean shift of $X_{i,j}$ and $Y_{i,j}$, the standard deviation σ_X and σ_Y are supposed to be the same. The out-of-control mean ratio is now equal to

$$z_1 = \frac{\mu_{0,X} + \delta_X \sigma_X}{\mu_{0,Y} + \delta_Y \sigma_Y} = \tau \times z_0 = \tau \times \frac{\mu_{0,X}}{\mu_{0,Y}},$$

Thus, the shift size τ can be expressed as

$$\tau = \frac{1 + \delta_X \gamma_X}{1 + \delta_Y \gamma_Y}$$

or equivalent,

$$1 + \delta_X \gamma_X = \tau(1 + \delta_Y \gamma_Y). \quad (23)$$

Now, if we express the mean vector and the variance-covariance matrix of $\overline{\mathbf{W}}_{i,j}^*$ in the form

$$\boldsymbol{\mu}_{\mathbf{W}^*} = \begin{pmatrix} \mu_{X^*} \\ \mu_{Y^*} \end{pmatrix} \text{ and } \boldsymbol{\Sigma}_{\mathbf{W}^*} = \begin{pmatrix} \sigma_{X^*}^2 & \rho^* \sigma_X \sigma_Y \\ \rho^* \sigma_X \sigma_Y & \sigma_{Y^*}^2 \end{pmatrix}, \quad (24)$$

the equations (21) and (22) lead to

$$\mu_{X^*} = a_X + \mu_X + \delta_X \sigma_X, \quad (25)$$

$$\mu_{Y^*} = a_Y + \mu_Y + \delta_Y \sigma_Y, \quad (26)$$

$$\sigma_{X^*}^2 = \sigma_X^2 + \frac{\sigma_{MX}^2}{m}, \quad (27)$$

$$\sigma_{Y^*}^2 = \sigma_Y^2 + \frac{\sigma_{MY}^2}{m}, \quad (28)$$

$$\rho^* = \frac{\rho \sigma_X \sigma_Y + \rho_M \frac{\sigma_{MX} \sigma_{MY}}{m}}{\sigma_{X^*} \sigma_{Y^*}}. \quad (29)$$

Therefore, the coefficients of variation $\gamma_{X^*} = \frac{\sigma_{X^*}}{\mu_{X^*}}$ and $\gamma_{Y^*} = \frac{\sigma_{Y^*}}{\mu_{Y^*}}$ of $\bar{X}_{i,j}^*$ and $\bar{Y}_{i,j}^*$ are equal to

$$\gamma_{X^*} = \frac{\sqrt{\sigma_X^2 + \frac{\sigma_{MX}^2}{m}}}{a_X + \mu_{0,X} + \delta_X \sigma_X}, \quad (30)$$

$$\gamma_{Y^*} = \frac{\sqrt{\sigma_Y^2 + \frac{\sigma_{MY}^2}{m}}}{a_Y + \mu_{0,Y} + \delta_Y \sigma_Y}. \quad (31)$$

If we divide the numerator of the fraction in (30) by σ_X , its denominator by $\mu_{0,X}$ and then replace $1 + \delta_X \sigma_X$ by $\tau(1 + \delta_Y \sigma_Y)$ as in (23), the coefficient of variation γ_{X^*} in (30) can be rewritten as

$$\gamma_{X^*} = \frac{\sqrt{1 + \frac{\eta_X^2}{m}}}{1 + \delta_X \gamma_X + \theta_X} \times \gamma_X = \frac{\sqrt{1 + \frac{\eta_X^2}{m}}}{\tau(1 + \delta_Y \gamma_Y) + \theta_X} \times \gamma_X \quad (32)$$

where $\eta_X = \frac{\sigma_{MX}}{\sigma_X}$, $\theta_X = \frac{a_X}{\mu_{0,X}}$, and $\gamma_X = \frac{\sigma_X}{\mu_{0,X}}$.

Similarly, the coefficients of variation γ_{Y^*} in (31) and the coefficient of correlation ρ^* in (29) can be expressed by

$$\gamma_{Y^*} = \frac{\sqrt{1 + \frac{\eta_Y^2}{m}}}{1 + \delta_Y \gamma_Y + \theta_Y} \times \gamma_Y, \quad (33)$$

$$\rho^* = \frac{\rho + \rho_M \frac{\eta_X \eta_Y}{m}}{\sqrt{1 + \eta_X^2/m} \sqrt{1 + \eta_Y^2/m}}, \quad (34)$$

where $\eta_Y = \frac{\sigma_{MY}}{\sigma_Y}$, $\theta_Y = \frac{a_Y}{\mu_{0,Y}}$ and $\gamma_Y = \frac{\sigma_Y}{\mu_{0,Y}}$. In addition, the standard-deviation ratio $\omega^* = \frac{\sigma_{X^*}}{\sigma_{Y^*}}$ is equal to

$$\omega^* = \sqrt{\frac{1 + \frac{\eta_X^2}{m}}{1 + \frac{\eta_Y^2}{m}}} \times \omega, \quad (35)$$

where $\omega = \frac{\sigma_X}{\sigma_Y}$. By these notations, it can be seen that the in-control and out-of-control ratio under the presence of the measurement error are

$$z_0^* = \frac{\mu_{0,X^*}}{\mu_{0,Y^*}} = \frac{\mu_{0,X} + a_X}{\mu_{0,Y} + a_Y} = \frac{1 + \theta_X}{1 + \theta_Y} \times z_0 \quad (36)$$

$$z_1^* = \frac{\mu_{1,X^*}}{\mu_{1,Y^*}} = \frac{a_X + \mu_{0,X} + \delta_X \sigma_X}{a_Y + \mu_{0,Y} + \delta_Y \sigma_Y} = \frac{1 + \theta_X + \delta_X \gamma_X}{1 + \theta_Y + \delta_Y \gamma_Y} \times z_0 \quad (37)$$

The equations (36)-(37) show that in general we do not have $z_1^* = \tau z_0^*$.

6 Design and implementation of the Shewhart-RZ control chart with measurement error

Under the presence of measurement error, the monitored statistic in (7) is of the form

$$\hat{Z}_i^* = \frac{\hat{\mu}_{X_i^*}}{\hat{\mu}_{Y_i^*}} = \frac{\bar{X}_i^*}{\bar{Y}_i^*} = \frac{\sum_{j=1}^n X_{i,j}^*}{\sum_{j=1}^n Y_{i,j}^*}. \quad (38)$$

where $\bar{X}_i^* = \frac{1}{n} \sum_{j=1}^n \bar{X}_{i,j}^*$, $\bar{Y}_i^* = \frac{1}{n} \sum_{j=1}^n \bar{Y}_{i,j}^*$, $\bar{X}_{i,j}^*$ and $\bar{Y}_{i,j}^*$ are two components of the bivariate normal vector $\bar{\mathbf{W}}_{i,j}^*$ in (20).

From their definition, it is easy to see that $\bar{X}_i^* \sim N(\mu_{X^*}, \frac{\sigma_{X^*}}{\sqrt{n}})$ and $\bar{Y}_i^* \sim N(\mu_{Y^*}, \frac{\sigma_{Y^*}}{\sqrt{n}})$, the coefficients of variation of $\bar{X}_i^*$ and $\bar{Y}_i^*$ are now

$$\gamma_{\bar{X}^*} = \frac{\sigma_{X^*}}{\mu_{X^*} \sqrt{n}} = \frac{\gamma_{X^*}}{\sqrt{n}}, \quad (39)$$

$$\gamma_{\bar{Y}^*} = \frac{\sigma_{Y^*}}{\mu_{Y^*} \sqrt{n}} = \frac{\gamma_{Y^*}}{\sqrt{n}}, \quad (40)$$

and the standard-deviation ratio ω_i^* of $\bar{X}_i^*$ and $\bar{Y}_i^*$ is

$$\omega_i^* = \frac{\sigma_{X^*}/\sqrt{n}}{\sigma_{Y^*}/\sqrt{n}} = \frac{\sigma_{X^*}}{\sigma_{Y^*}} = \omega^* \quad (41)$$

The *c.d.f* and the inverse *c.d.f* of $\hat{Z}_i^*$ now can be obtained from (11) and (12) where γ_X , γ_Y , ω and ρ are replaced by $\gamma_{\bar{X}^*}$, $\gamma_{\bar{Y}^*}$, ω^* and ρ^* defined in (39), (40), (41) and (34).

The design and the implementation of the one-sided Shewhart-RZ control chart under the presence of measurement error are similar to those of the one-sided Shewhart-RZ control chart without measurement error. The different is that the distribution of $\hat{Z}_i$ in (13)-(14) and (16)-(17) should be replaced by the distribution of $\hat{Z}_i^*$.

In the previous section, we evaluate the performance of the Shewhart-RZ control chart through the *ARL*. This measurement is calculated based on a predetermined specific shift size. However, it is no doubt that specific

size of the shift in the ratio can not be predetermined exactly. Therefore, in practice, quality practitioners prefer to consider a range of the shift size, say $\Omega = [a, b]$ rather than a particular size. Moreover, the use of a uniform distribution has been widely suggested to represent the unknown shift sizes in the literature. Following this argument, we now evaluate the performance of the proposed charts in the presence of measurement error through the *EARL* (expected average run length), which is defined as

$$EARL = \int_{\Omega} ARL \times f_{\tau}(\tau) d\tau, \quad (42)$$

where $f_{\tau}(\tau) = \frac{1}{b-a}$ for $\tau \in \Omega$. Similar to Tran et al.⁸, the following two different ranges of the shift size are considered: $\Omega_D = [0.9, 1)$ for a decreasing case of τ and $\Omega_I = [1, 1.1)$ for an increasing case of τ .

7 The effect of measurement error on the one-sided Shewhart-RZ control charts

The effect of measurement error on the proposed charts is presented in this section. Without loss of generality, the in-control values of the ratio and the *ARL* are supposed to be $z_0 = 1$ and $ARL_0 = 200$. We also suppose that the size of the mean shift of $Y_{i,j}$ is $\delta_Y = 1$. Moreover, the values of γ_X , γ_Y and ρ_0 are considered the same as those in the section 4, except for the case of n : we consider only two values of the sample size, $n \in \{1, 15\}$, to avoid the cumbersome in presented results.

Table 1 (the rightmost block titled “with measurement error”) shows the control limits LCL^- and UCL^+ of the one-sided Shewhart-RZ control charts in the presence of measurement error for the case $\theta_X = \theta_Y = 0.01$, $\eta_X = \eta_Y = 0.01$ and $\rho_M = 0.5$. As can be seen from this table, the measurement error affects the value of the control limits. However, the behavior of the control limits in the presence of the measurement error is still the same as that in the case of no measurement error. For example, we still have $UCL^+ = 1/LCL^-$ when $\gamma_X = \gamma_Y$.

In order to see the effect of precision errors (represented by η_X and η_Y) on the performance of the one-sided Shewhart-RZ charts, we fix the value of $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$, $\rho_M = 0$, $\theta_X = \theta_Y = 0$, $\rho_0 = \rho_1 = -0.8$ or $\rho_0 = -0.4, \rho_1 = -0.8$, and we consider a range of η_X and η_Y , which is $\eta_X \in \{0, 0.1, 0.2, \dots, 1\}$ and $\eta_Y \in \{0, 0.1, 0.2, \dots, 1\}$. The corresponding *EARL* values are presented in Figures 2-3. Since the increase of η_X and η_Y leads to the increase of the *EARL*, we can say that the precision errors have a negative impact on the charts’ performance. For example, given $n = 1$, $\Omega_D = (1, 1.1]$, $\rho_0 = \rho_1 = 0.8$, $\gamma_X = \gamma_Y = 0.2$, we obtain $EARL = 151.93$ when $\eta_X = \eta_Y = 0.1$ and $EARL = 168.85$ when $\eta_X = \eta_Y = 1$ (Figure 2). However, this influence is negligible when the precision errors are not too

large. For instance, in Figure 3 with $n = 1$, $\Omega_I = [0.9, 1)$, $\rho_0 = 0.4$, $\rho_1 = 0.8$, $\gamma_X = \gamma_Y = 0.01$, we have $EARL = 5.23$ when $\eta_X = \eta_Y = 0.5$ compared to $EARL = 4.85$ when $\eta_X = \eta_Y = 0.0$, which corresponds to the case of no measurement error.

PLEASE INSERT FIGURE 2 ABOUT HERE
PLEASE INSERT FIGURE 3 ABOUT HERE

We investigate the effect of accuracy errors (represented by θ_X and θ_Y) on the global performance of the Shewhart-RZ control chart in Figures 4-5 by allowing θ_X and θ_Y to take the value in $\{0, 0.005, 0.01, \dots, 0.05\}$ and fixing $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$, $\rho_M = 0$, $\eta_X = \eta_Y = 0$, $\rho_0 = \rho_1 = -0.8$ (Figure 2) and $\rho_0 = -0.4$, $\rho_1 = -0.8$ (Figure 3). These figures show that the effect of θ_X and θ_Y on the value of $EARL$ depends on the value of ρ_0 and ρ_1 . In this study, when $\rho_0 = \rho_1 = -0.8$, the increase of θ_X and the decrease of θ_Y lead to the increase of the $EARL$ (Figure 2). In contrast, when $\rho_0 = -0.4$, $\rho_1 = -0.8$, the $EARL$ increases when θ_X decreases and θ_Y increases. Take the case $n = 1$, $\Omega_I = [0.9, 1)$, $\rho_0 = \rho_1 = 0.8$, $\gamma_X = \gamma_Y = 0.2$ in Figure 4 as an example: we have $EARL = 104.60$ when $\theta_X = 0.005$, $\theta_Y = 0.05$ and $EARL = 113.56$ when $\theta_X = 0.05$, $\theta_Y = 0.005$. Moreover, it is also important to see that the larger value of n improves significantly the charts' performance: the values of $EARL$ corresponding to $n = 15$ are always smaller than those corresponding to $n = 1$ regardless of the presence of measurement error.

PLEASE INSERT FIGURE 4 ABOUT HERE
PLEASE INSERT FIGURE 5 ABOUT HERE

The effect of ρ_M on the one-sided Shewhart-RZ control charts is illustrated in Figure 6 (for $\rho_0 = \rho_1 = -0.8$) and Figure 7 (for $\rho_0 = -0.4$, $\rho_1 = -0.8$), where we fix $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$, $\theta_X = \theta_Y = 0.05$, $\eta_X = \eta_Y = 0.28$ and we let ρ_M to take the values in $\{-1, -0.9, \dots, 0.9, 1\}$. As can be seen from these figures, the larger the value of ρ_M is, the smaller the value of $EARL$ is. For example, with $n = 1$, $\Omega_D = [0.9, 1)$, $\rho_0 = \rho_1 = -0.8$, $\gamma_X = \gamma_Y = 0.2$, we have $EARL = 58.60$ when $\rho_M = -0.8$ and $EARL = 56.19$ when $\rho_M = 0.8$ (Figure 7).

PLEASE INSERT FIGURE 6 ABOUT HERE
PLEASE INSERT FIGURE 7 ABOUT HERE

It is recommended in several studies in the literature that take multiple measurements per item is a way to compensate for the negative effect of measurement error on the performance of a control chart. In order to check if this property is still the case for the Shewhart-RZ control chart, we calculate the value of $EARL$ when m increases from 1 to 10 given the values of $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$, $\theta_X = \theta_Y = 0.05$, and $\eta_X = \eta_Y = 0.28$.

The obtained results are presented in Figures 8-9. These results show a different conclusion that the increase of m does not improve significantly the Shewhart-RZ charts' performance. For example, with $n = 1$, $\Omega_D = [0.9, 1)$, $\gamma_X = \gamma_Y = 0.2$, $\theta_X = \theta_Y = 0.05$, $\eta_X = \eta_Y = 0.28$ and $\rho_0 = -0.4$, $\rho_1 = -0.8$ in Figure 9, we obtain an insignificant decrease from $EARL = 58.54$ when $m = 1$ to $EARL = 58.18$ when $m = 10$.

PLEASE INSERT FIGURE 8 ABOUT HERE
PLEASE INSERT FIGURE 9 ABOUT HERE

8 Illustrative example

In this section, we present an illustrative example of the implementation of the one-sided Shewhart-RZ control chart in the presence of the measurement error. We consider a real situation of managing waste batteries in some battery recycling plants in Italy, which was introduced in Tran et al.⁸.

At the first step of the recycling process, the batteries are received by collecting facilities incoming disposed material into designated drums, sacks or boxes, denoted as "batches". Many disposed materials that are not recyclable batteries like small electronic devices, metals and other kinds of waste might be included in these batches. To reduce the recycling cost, removing these disposed materials from the batches is required. In a recycling plant, the ratio Z of recyclable batteries weight (denoted by X) to total batch weight (denoted by Y) is monitored to quantify the cost. Similar to Tran et al.⁸, we suppose that a value of 0.95 is the value of interest for the in-control ratio z_0 to avoid an economic loss.

At regular intervals $i = 1, 2, \dots$, a sample of $n = 5$ is collected with batches having nominal weight 100kg in the process of monitoring the ratio Z . Because of the variability, the batch weight is considered as a random normal variable $Y \sim N(100, 1)$. The recyclable batteries' weight within each batch is also considered as a normal random variable with a mean of $\mu_X = 95$ kg. The sample average weights $\bar{X}_i^* = \frac{1}{n} \sum_{j=1}^n X_{i,j}^*$ and $\bar{Y}_i^* = \frac{1}{n} \sum_{j=1}^n Y_{i,j}^*$ are recorded. a set of simulated samples of incoming material in the battery recycling process introduced in Tran et al.⁸ has been reproduced in Table 6. A decreasing shift has been simulated from sample #11 with the size up to 1% of the in-control ratio z_0 . Moreover, the coefficients of variations of two variables are $\gamma_X = 0.01$ and $\gamma_Y = 0.01$, and the in-control correlation coefficient between them is $\rho_0 = 0.8$.

We suppose the following parameters of the linear covariate error model: $\theta_X = \theta_Y = 0$, $\eta_X = \eta_Y = 0.28$, $\rho_1 = 0.8$ and $\rho_M = 0$. Also, we apply a smoothing value of $\lambda = 0.2$. Then, the control limit of the Shewhart-RZ⁻ control chart with measurement errors is $LCL^- = 0.9419487$.

The Shewhart-RZ⁻ control chart corresponding to this experiment is illustrated in Figure 10. As can be seen from this figure, the samples #11 is

plotted below the control limit, indicating that an assignable cause may have appeared to shift the process to the out-of-control condition. This result is in accord with the finding in Tran et al.⁸.

PLEASE INSERT TABLE 6 ABOUT HERE

PLEASE INSERT FIGURE 10 ABOUT HERE

9 Concluding remarks

In this paper, we have proposed two one-sided Shewhart control charts to monitor the ratio between two random normal variables. This is to overcome the *ARL*-biased problem of the two-sided Shewhart-RZ control chart designed in Celano and Castagliola⁹. These one-sided charts also outperform the two-sided Shewhart-RZ control chart in detecting process shifts. Moreover, we have modeled the change of parameters when the process is shifted from an in-control condition to an out-of-control status under the presence of measurement error in detail. The negative effect of measurement errors on the performance of the two one-sided Shewhart-RZ charts has been also explored. Reducing these negative effects on the ratio control chart by combining with adaptive strategies like variable sampling interval or with run rules could be an interest in future research.

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Table 1: Values of LCL^- (first row) and UCL^+ (second row) for the one-sided Shewhart-RZ control charts in the presence of Measurement Error, for $z_0 = 1$, $ARL_0 = 200$, $\theta_X = \theta_Y = 0.01$, $\eta_X = \eta_Y = 0.28$, $\rho_M = 0.5$, $n \in \{1, 5, 7, 10, 15\}$, $\gamma_X \in \{0.01, 0.2\}$, $\gamma_Y \in \{0.01, 0.2\}$ and $\rho_0 \in \{-0.8, -0.4, 0, 0.4, 0.8\}$

			Without measurement error					With measurement error				
γ_X	γ_Y	ρ_0	$n = 1$	$n = 5$	$n = 7$	$n = 10$	$n = 15$	$n = 1$	$n = 5$	$n = 7$	$n = 10$	$n = 15$
0.01	0.01	−0.8	0.9523	0.9784	0.9817	0.9847	0.9875	0.9527	0.9786	0.9819	0.9848	0.9876
			1.0501	1.0221	1.0186	1.0156	1.0127	1.0496	1.0219	1.0185	1.0154	1.0126
		−0.4	0.9578	0.9809	0.9838	0.9865	0.9889	0.9580	0.9810	0.9839	0.9865	0.9890
			1.0441	1.0195	1.0164	1.0137	1.0112	1.0438	1.0193	1.0163	1.0136	1.0111
		0.0	0.9642	0.9838	0.9863	0.9885	0.9906	0.9642	0.9838	0.9863	0.9886	0.9906
			1.0371	1.0164	1.0139	1.0116	1.0095	1.0371	1.0164	1.0139	1.0116	1.0094
		0.4	0.9722	0.9875	0.9894	0.9911	0.9927	0.9718	0.9873	0.9893	0.9910	0.9927
			1.0286	1.0127	1.0107	1.0090	1.0073	1.0290	1.0129	1.0109	1.0091	1.0074
		0.8	0.9838	0.9927	0.9939	0.9949	0.9958	0.9827	0.9922	0.9934	0.9945	0.9955
			1.0164	1.0073	1.0062	1.0052	1.0042	1.0176	1.0078	1.0066	1.0055	1.0045
0.20	0.20	−0.8	0.3375	0.6405	0.6877	0.7320	0.7757	0.4141	0.6904	0.7321	0.7710	0.8091
			2.9631	1.5613	1.4542	1.3662	1.2891	2.4147	1.4483	1.3658	1.2970	1.2359
		−0.4	0.3800	0.6746	0.7184	0.7593	0.7992	0.4561	0.7203	0.7588	0.7944	0.8291
			2.6316	1.4823	1.3919	1.3171	1.2512	2.1924	1.3883	1.3179	1.2588	1.2062
		0.0	0.4377	0.7166	0.7559	0.7922	0.8274	0.5109	0.7564	0.7908	0.8222	0.8527
			2.2849	1.3955	1.3229	1.2624	1.2087	1.9574	1.3220	1.2646	1.2162	1.1728
		0.4	0.5236	0.7721	0.8049	0.8347	0.8634	0.5883	0.8032	0.8317	0.8576	0.8825
			1.9100	1.2952	1.2424	1.1980	1.1582	1.6997	1.2451	1.2024	1.1660	1.1332
		0.8	0.6853	0.8611	0.8821	0.9009	0.9186	0.7212	0.8744	0.8933	0.9103	0.9263
			1.4592	1.1614	1.1337	1.1100	1.0886	1.3866	1.1437	1.1194	1.0986	1.0795
0.01	0.20	−0.8	0.6462	0.8052	0.8304	0.8542	0.8778	0.6823	0.8290	0.8517	0.8729	0.8939
			2.1053	1.3114	1.2516	1.2025	1.1596	1.8208	1.2553	1.2078	1.1684	1.1335
		−0.4	0.6527	0.8088	0.8336	0.8569	0.8801	0.6878	0.8319	0.8542	0.8751	0.8957
			2.0843	1.3056	1.2468	1.1987	1.1566	1.8063	1.2508	1.2042	1.1654	1.1311
		0.0	0.6594	0.8125	0.8368	0.8597	0.8824	0.6934	0.8350	0.8569	0.8774	0.8976
			2.0632	1.2996	1.2420	1.1948	1.1536	1.7916	1.2463	1.2005	1.1624	1.1288
		0.4	0.6662	0.8162	0.8401	0.8625	0.8848	0.6992	0.8381	0.8596	0.8797	0.8995
			2.0419	1.2936	1.2372	1.1909	1.1505	1.7769	1.2417	1.1967	1.1594	1.1264
		0.8	0.6734	0.8201	0.8434	0.8654	0.8872	0.7051	0.8412	0.8623	0.8820	0.9015
			2.0203	1.2875	1.2322	1.1869	1.1473	1.7619	1.2370	1.1929	1.1563	1.1239
0.20	0.01	−0.8	0.4750	0.7625	0.7990	0.8316	0.8624	0.4668	0.7591	0.7961	0.8292	0.8604
			1.5476	1.2420	1.2042	1.1706	1.1392	1.5540	1.2451	1.2069	1.1729	1.1410
		−0.4	0.4798	0.7659	0.8020	0.8343	0.8646	0.4712	0.7623	0.7990	0.8317	0.8625
			1.5322	1.2364	1.1997	1.1669	1.1362	1.5393	1.2398	1.2025	1.1693	1.1382
		0.0	0.4847	0.7694	0.8051	0.8369	0.8669	0.4758	0.7656	0.8019	0.8342	0.8647
			1.5166	1.2308	1.1951	1.1632	1.1332	1.5246	1.2345	1.1982	1.1658	1.1354
		0.4	0.4897	0.7730	0.8083	0.8397	0.8692	0.4805	0.7690	0.8049	0.8368	0.8669
			1.5010	1.2251	1.1904	1.1594	1.1302	1.5097	1.2291	1.1937	1.1622	1.1325
		0.8	0.4950	0.7767	0.8115	0.8425	0.8716	0.4854	0.7724	0.8079	0.8395	0.8691
			1.4851	1.2193	1.1856	1.1555	1.1271	1.4946	1.2236	1.1892	1.1585	1.1296

Table 2: *ARL* of the one-sided Shewhart-RZ control charts for $\gamma_X \in \{0.01, 0.2\}$, $\gamma_Y \in \{0.01, 0.2\}$, $\gamma_X = \gamma_Y$, $\rho_0 \in \{-0.8, -0.4, 0, 0.4, 0.8\}$, $\rho_0 = \rho_1$, $n \in \{1, 5, 7, 10, 15\}$.

τ	$(\gamma_X = 0.01, \gamma_Y = 0.01)$					$(\gamma_X = 0.2, \gamma_Y = 0.2)$				
	$n = 1$	$n = 5$	$n = 7$	$n = 10$	$n = 15$	$n = 1$	$n = 5$	$n = 7$	$n = 10$	$n = 15$
$\rho_0 = \rho_1 = -0.8$										
0.90	1.0	1.0	1.0	1.0	1.0	112.1	42.1	32.0	23.2	15.4
0.95	1.8	1.0	1.0	1.0	1.0	150.7	90.5	77.8	64.7	50.8
0.98	15.3	2.4	1.7	1.3	1.1	178.9	145.2	136.3	126.0	113.4
0.99	49.1	12.2	8.3	5.4	3.3	189.2	170.3	164.9	158.5	150.1
1.01	49.8	12.5	8.5	5.6	3.4	189.3	170.6	165.3	158.8	150.6
1.02	16.0	2.5	1.7	1.3	1.1	179.3	146.1	137.3	127.1	114.6
1.05	2.0	1.0	1.0	1.0	1.0	152.8	93.9	81.3	68.2	54.0
1.10	1.0	1.0	1.0	1.0	1.0	118.4	48.3	37.5	27.7	18.8
$\rho_0 = \rho_1 = -0.4$										
0.90	1.0	1.0	1.0	1.0	1.0	105.5	35.2	26.0	18.3	11.8
0.95	1.5	1.0	1.0	1.0	1.0	146.4	82.1	69.3	56.4	43.1
0.98	11.7	1.8	1.4	1.1	1.0	176.8	139.5	129.8	118.8	105.5
0.99	41.5	9.2	6.2	4.0	2.5	188.1	166.9	160.9	153.8	144.7
1.01	42.1	9.4	6.3	4.1	2.5	188.2	167.2	161.3	154.2	145.1
1.02	12.2	1.9	1.4	1.1	1.0	177.3	140.5	130.9	120.0	106.8
1.05	1.6	1.0	1.0	1.0	1.0	148.6	85.6	72.8	59.8	46.1
1.10	1.0	1.0	1.0	1.0	1.0	112.1	40.9	30.9	22.2	14.6
$\rho_0 = \rho_1 = 0.0$										
0.90	1.0	1.0	1.0	1.0	1.0	95.7	26.8	19.1	12.9	8.0
0.95	1.2	1.0	1.0	1.0	1.0	139.7	70.7	58.1	45.8	33.7
0.98	8.0	1.4	1.1	1.0	1.0	173.6	131.0	120.4	108.5	94.4
0.99	32.2	6.2	4.1	2.7	1.8	186.4	161.7	154.9	146.8	136.6
1.01	32.7	6.3	4.2	2.8	1.8	186.5	162.0	155.2	147.2	137.1
1.02	8.4	1.4	1.1	1.0	1.0	174.1	132.1	121.6	109.8	95.8
1.05	1.2	1.0	1.0	1.0	1.0	142.1	74.2	61.4	48.9	36.4
1.10	1.0	1.0	1.0	1.0	1.0	102.7	31.8	23.1	16.0	10.1
$\rho_0 = \rho_1 = 0.4$										
0.90	1.0	1.0	1.0	1.0	1.0	79.3	16.5	11.1	7.2	4.3
0.95	1.0	1.0	1.0	1.0	1.0	127.5	53.7	42.0	31.5	21.7
0.98	4.3	1.1	1.0	1.0	1.0	167.6	116.5	104.6	91.7	76.9
0.99	20.6	3.3	2.3	1.6	1.2	183.2	152.3	144.1	134.5	122.7
1.01	21.0	3.4	2.3	1.6	1.2	183.3	152.7	144.6	135.1	123.3
1.02	4.5	1.1	1.0	1.0	1.0	168.1	117.7	105.9	93.0	78.3
1.05	1.0	1.0	1.0	1.0	1.0	130.4	57.0	45.1	34.1	23.8
1.10	1.0	1.0	1.0	1.0	1.0	86.6	20.2	13.9	9.1	5.5
$\rho_0 = \rho_1 = 0.8$										
0.90	1.0	1.0	1.0	1.0	1.0	42.3	4.6	3.0	2.0	1.4
0.95	1.0	1.0	1.0	1.0	1.0	93.8	23.3	16.2	10.8	6.6
0.98	1.4	1.0	1.0	1.0	1.0	148.6	80.2	67.1	54.2	40.9
0.99	6.2	1.2	1.1	1.0	1.0	172.6	125.7	114.3	101.9	87.3
1.01	6.3	1.2	1.1	1.0	1.0	172.8	126.2	115.0	102.5	88.0
1.02	1.4	1.0	1.0	1.0	1.0	149.5	81.6	68.5	55.5	42.1
1.05	1.0	1.0	1.0	1.0	1.0	97.3	25.5	18.0	12.0	7.4
1.10	1.0	1.0	1.0	1.0	1.0	49.0	5.9	3.8	2.4	1.6

Table 3: *ARL* of the one-sided Shewhart-RZ control charts for $\gamma_X \in \{0.01, 0.2\}$, $\gamma_Y \in \{0.01, 0.2\}$, $\gamma_X \neq \gamma_Y$, $\rho_0 \in \{-0.8, -0.4, 0, 0.4, 0.8\}$, $\rho_0 = \rho_1$, $n \in \{1, 5, 7, 10, 15\}$.

τ	$(\gamma_X = 0.01, \gamma_Y = 0.2)$					$(\gamma_X = 0.2, \gamma_Y = 0.01)$				
	$n = 1$	$n = 5$	$n = 7$	$n = 10$	$n = 15$	$n = 1$	$n = 5$	$n = 7$	$n = 10$	$n = 15$
$\rho_0 = \rho_1 = -0.8$										
0.90	31.7	9.6	6.9	4.8	3.1	96.3	20.3	13.2	8.1	4.6
0.95	75.4	36.4	29.1	22.3	15.7	140.3	61.4	47.6	35.1	23.6
0.98	133.6	96.7	87.1	76.6	64.3	174.0	123.9	111.0	96.9	80.7
0.99	163.1	138.0	130.7	122.1	111.2	186.6	157.2	148.7	138.7	126.1
1.01	186.8	157.6	149.1	139.2	126.6	163.4	138.5	131.2	122.6	111.9
1.02	174.5	125.0	112.3	98.3	82.1	134.7	98.0	88.5	77.9	65.7
1.05	142.7	64.8	50.8	37.9	25.8	78.8	39.2	31.6	24.3	17.4
1.10	103.3	24.6	16.4	10.3	5.9	36.8	11.9	8.7	6.1	3.9
$\rho_0 = \rho_1 = -0.4$										
0.90	30.4	9.2	6.6	4.6	3.0	95.6	19.6	12.7	7.8	4.4
0.95	73.6	35.2	28.1	21.4	15.1	139.8	60.3	46.6	34.2	22.9
0.98	132.2	95.2	85.6	75.1	62.9	173.8	123.0	110.0	95.8	79.6
0.99	162.2	136.9	129.5	120.8	109.9	186.5	156.7	148.0	137.9	125.1
1.01	186.6	157.1	148.5	138.4	125.7	162.5	137.4	130.0	121.4	110.5
1.02	174.3	124.2	111.3	97.2	81.0	133.2	96.5	87.0	76.5	64.3
1.05	142.3	63.8	49.8	37.0	25.1	76.9	37.9	30.5	23.4	16.7
1.10	102.6	23.9	15.9	9.9	5.7	35.4	11.4	8.3	5.8	3.8
$\rho_0 = \rho_1 = 0.0$										
0.90	29.1	8.7	6.3	4.4	2.9	94.9	19.0	12.2	7.4	4.2
0.95	71.6	34.0	27.1	20.6	14.4	139.3	59.3	45.6	33.3	22.1
0.98	130.6	93.6	84.0	73.6	61.5	173.5	122.1	109.0	94.7	78.4
0.99	161.2	135.6	128.2	119.5	108.5	186.4	156.1	147.3	137.0	124.1
1.01	186.5	156.5	147.8	137.5	124.7	161.5	136.1	128.7	120.0	109.1
1.02	174.0	123.3	110.3	96.1	79.8	131.7	94.9	85.4	74.9	62.8
1.05	141.8	62.7	48.8	36.0	24.3	75.0	36.6	29.4	22.5	16.0
1.10	101.9	23.2	15.3	9.5	5.4	34.0	10.9	7.9	5.5	3.6
$\rho_0 = \rho_1 = 0.4$										
0.90	27.8	8.3	6.0	4.1	2.7	94.1	18.4	11.7	7.1	4.0
0.95	69.6	32.7	26.0	19.7	13.8	138.8	58.2	44.6	32.3	21.4
0.98	128.9	91.9	82.4	72.0	60.0	173.3	121.2	107.9	93.5	77.1
0.99	160.1	134.3	126.8	118.0	107.0	186.2	155.5	146.6	136.1	123.1
1.01	186.4	155.9	147.0	136.7	123.7	160.5	134.9	127.4	118.6	107.7
1.02	173.8	122.3	109.2	94.9	78.5	130.0	93.2	83.8	73.3	61.3
1.05	141.3	61.6	47.7	35.0	23.5	73.0	35.3	28.3	21.6	15.2
1.10	101.2	22.5	14.7	9.1	5.2	32.5	10.3	7.5	5.2	3.4
$\rho_0 = \rho_1 = 0.8$										
0.90	26.4	7.8	5.6	3.9	2.6	93.4	17.7	11.3	6.8	3.8
0.95	67.5	31.5	24.9	18.8	13.1	138.3	57.1	43.5	31.4	20.6
0.98	127.2	90.1	80.7	70.3	58.4	173.0	120.2	106.8	92.3	75.8
0.99	159.0	133.0	125.4	116.6	105.5	186.1	154.9	145.8	135.2	122.0
1.01	186.2	155.3	146.3	135.7	122.6	159.3	133.5	126.0	117.2	106.1
1.02	173.5	121.4	108.1	93.7	77.2	128.3	91.5	82.0	71.6	59.7
1.05	140.8	60.5	46.6	34.0	22.7	70.8	34.0	27.1	20.7	14.5
1.10	100.4	21.7	14.2	8.7	4.9	31.0	9.8	7.1	4.9	3.2

Table 4: *ARL* of the one-sided Shewhart-RZ control charts for $\gamma_X \in \{0.01, 0.2\}$, $\gamma_Y \in \{0.01, 0.2\}$, $\gamma_X = \gamma_Y$, $\rho_0 \in \{-0.8, -0.4, 0, 0.4, 0.8\}$, $\rho_0 \neq \rho_1$, $n \in \{1, 5, 7, 10, 15\}$.

τ	$(\gamma_X = 0.01, \gamma_Y = 0.01)$					$(\gamma_X = 0.2, \gamma_Y = 0.2)$				
	$n = 1$	$n = 5$	$n = 7$	$n = 10$	$n = 15$	$n = 1$	$n = 5$	$n = 7$	$n = 10$	$n = 15$
$\rho_0 = -0.4, \rho_1 = -0.2$										
0.90	1.0	1.0	1.0	1.0	1.0	156.1	49.8	35.5	23.8	14.4
0.95	1.4	1.0	1.0	1.0	1.0	221.6	130.2	108.0	85.9	63.3
0.98	14.4	1.8	1.3	1.1	1.0	271.1	237.2	220.5	200.6	176.0
0.99	60.9	10.9	7.0	4.3	2.5	289.4	290.7	281.6	269.4	252.5
1.01	61.9	11.2	7.2	4.4	2.6	289.6	291.3	282.3	270.1	253.4
1.02	15.1	1.9	1.4	1.1	1.0	271.8	239.1	222.7	203.0	178.5
1.05	1.6	1.0	1.0	1.0	1.0	225.3	136.4	114.2	91.7	68.4
1.10	1.0	1.0	1.0	1.0	1.0	166.6	59.1	43.1	29.6	18.5
$\rho_0 = -0.4, \rho_1 = -0.8$										
0.90	1.0	1.0	1.0	1.0	1.0	59.1	21.7	16.9	12.7	8.8
0.95	1.5	1.0	1.0	1.0	1.0	78.9	43.4	37.6	31.7	25.4
0.98	8.8	1.8	1.4	1.2	1.0	93.4	66.8	62.5	57.9	52.4
0.99	24.6	7.2	5.2	3.6	2.4	98.7	77.4	74.4	71.3	67.5
1.01	24.8	7.4	5.3	3.7	2.5	98.7	77.5	74.6	71.4	67.7
1.02	9.1	1.9	1.5	1.2	1.0	93.6	67.2	63.0	58.3	52.9
1.05	1.6	1.0	1.0	1.0	1.0	80.0	44.9	39.1	33.2	26.9
1.10	1.0	1.0	1.0	1.0	1.0	62.3	24.6	19.5	14.9	10.6
$\rho_0 = 0.4, \rho_1 = 0.2$										
0.90	1.0	1.0	1.0	1.0	1.0	42.8	11.2	8.2	5.8	3.8
0.95	1.0	1.0	1.0	1.0	1.0	64.4	28.6	23.4	18.6	13.9
0.98	3.8	1.1	1.0	1.0	1.0	81.7	52.7	48.0	43.1	37.4
0.99	13.3	3.1	2.2	1.6	1.2	88.3	65.2	61.8	58.2	53.9
1.01	13.5	3.1	2.3	1.7	1.3	88.4	65.3	62.0	58.4	54.1
1.02	4.0	1.1	1.0	1.0	1.0	81.9	53.2	48.5	43.6	37.9
1.05	1.1	1.0	1.0	1.0	1.0	65.6	29.9	24.8	19.8	14.9
1.10	1.0	1.0	1.0	1.0	1.0	46.2	13.2	9.8	7.0	4.7
$\rho_0 = 0.4, \rho_1 = 0.8$										
0.90	1.0	1.0	1.0	1.0	1.0	1896.1	238.2	93.6	32.5	9.8
0.95	1.0	1.0	1.0	1.0	1.0	3636.7	4118.2	2539.1	1311.8	527.7
0.98	9.8	1.0	1.0	1.0	1.0	5166.3	25821.2	24225.5	20072.3	14146.4
0.99	491.2	5.5	2.5	1.4	1.0	5772.3	48187.6	53082.5	53249.5	47992.7
1.01	516.4	5.8	2.6	1.4	1.1	5778.6	48487.2	53500.0	53774.2	48590.5
1.02	10.9	1.0	1.0	1.0	1.0	5189.1	26458.4	24975.6	20843.3	14824.3
1.05	1.0	1.0	1.0	1.0	1.0	3743.4	4752.0	3018.0	1609.2	669.9
1.10	1.0	1.0	1.0	1.0	1.0	2148.4	389.4	161.8	58.0	17.3

Table 5: *ARL* of the one-sided Shewhart-RZ control charts for $\gamma_X \in \{0.01, 0.2\}$, $\gamma_Y \in \{0.01, 0.2\}$, $\gamma_X \neq \gamma_Y$, $\rho_0 \in \{-0.8, -0.4, 0, 0.4, 0.8\}$, $\rho_0 \neq \rho_1$, $n \in \{1, 5, 7, 10, 15\}$.

τ	$(\gamma_X = 0.01, \gamma_Y = 0.2)$					$(\gamma_X = 0.2, \gamma_Y = 0.01)$				
	$n = 1$	$n = 5$	$n = 7$	$n = 10$	$n = 15$	$n = 1$	$n = 5$	$n = 7$	$n = 10$	$n = 15$
$\rho_0 = -0.4, \rho_1 = -0.2$										
0.90	32.2	9.4	6.7	4.6	3.0	98.7	20.2	13.0	7.9	4.4
0.95	79.6	37.0	29.4	22.2	15.5	144.6	62.9	48.5	35.5	23.6
0.98	145.6	102.3	91.6	80.0	66.7	179.9	129.4	115.8	100.9	83.7
0.99	179.9	148.3	139.8	130.0	117.8	193.2	165.3	156.4	145.8	132.4
1.01	193.3	165.7	156.8	146.3	133.0	180.2	148.9	140.4	130.6	118.5
1.02	180.4	130.6	117.2	102.3	85.2	146.8	103.7	93.1	81.5	68.2
1.05	147.2	66.6	51.9	38.4	25.9	83.4	39.9	31.9	24.4	17.2
1.10	106.0	24.7	16.3	10.1	5.7	37.6	11.7	8.5	5.9	3.8
$\rho_0 = -0.4, \rho_1 = -0.8$										
0.90	27.5	8.8	6.4	4.5	3.0	89.8	18.6	12.2	7.5	4.3
0.95	63.5	32.1	25.9	19.9	14.2	130.9	55.7	43.2	31.8	21.5
0.98	110.5	83.2	75.4	66.7	56.4	162.4	111.7	99.8	86.9	72.3
0.99	134.0	117.7	112.1	105.2	96.4	174.2	141.5	133.3	123.9	112.3
1.01	174.3	141.8	133.6	124.3	112.8	134.3	118.1	112.5	105.7	96.9
1.02	162.8	112.7	100.9	88.1	73.6	111.3	84.3	76.5	67.8	57.5
1.05	133.2	58.8	46.1	34.4	23.5	66.3	34.4	28.0	21.7	15.7
1.10	96.3	22.6	15.1	9.5	5.5	31.8	10.8	8.0	5.6	3.7
$\rho_0 = 0.4, \rho_1 = 0.2$										
0.90	26.3	8.1	5.9	4.1	2.7	91.0	17.9	11.5	7.0	4.0
0.95	64.2	31.1	24.9	19.0	13.4	134.0	55.7	42.8	31.1	20.7
0.98	116.6	85.3	76.8	67.4	56.5	167.1	115.0	102.4	88.7	73.2
0.99	143.8	123.6	117.1	109.4	99.6	179.6	147.1	138.4	128.4	116.1
1.01	179.7	147.5	138.9	128.9	116.6	144.1	124.1	117.6	109.9	100.2
1.02	167.6	116.1	103.6	90.0	74.6	117.6	86.5	78.1	68.7	57.7
1.05	136.4	59.0	45.7	33.7	22.7	67.2	33.5	27.0	20.8	14.8
1.10	97.8	21.8	14.4	8.9	5.1	30.6	10.0	7.3	5.1	3.4
$\rho_0 = 0.4, \rho_1 = 0.8$										
0.90	31.3	8.7	6.2	4.2	2.7	100.9	19.5	12.3	7.4	4.1
0.95	83.1	36.5	28.6	21.3	14.7	149.3	63.7	48.6	35.0	22.9
0.98	160.7	107.8	95.7	82.7	68.1	186.7	135.2	120.7	104.6	86.0
0.99	202.7	160.8	150.6	139.0	124.9	200.8	174.6	165.3	153.9	139.3
1.01	201.0	175.1	165.8	154.5	140.0	203.1	161.4	151.2	139.7	125.7
1.02	187.3	136.6	122.2	106.1	87.6	162.1	109.5	97.4	84.4	69.7
1.05	152.0	67.6	52.1	38.0	25.2	87.4	39.5	31.2	23.5	16.3
1.10	108.5	24.0	15.6	9.5	5.3	37.0	10.9	7.8	5.4	3.5

Figure 2: The effect of η_X and η_Y on the overall performance of the Shewhart-RZ control chart in the presence of measurement error for $\theta_X = \theta_Y = 0$, $\rho_M = 0$, $n \in \{1, 15\}$, $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$, and $\rho_0 = \rho_1$.

Figure 3: The effect of η_X and η_Y on the overall performance of the Shewhart-RZ control chart in the presence of measurement error for $\theta_X = \theta_Y = 0$, $\rho_M = 0$, $n \in \{1, 15\}$, $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$, and $\rho_0 \neq \rho_1$.

Figure 4: The effect of θ_X and θ_Y on the overall performance of the Shewhart-RZ control chart in the presence of measurement error for $\eta_X = \eta_Y = 0$, $\rho_M = 0$, $n \in \{1, 15\}$, $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$, and $\rho_0 = \rho_1$.

Figure 5: The effect of θ_X and θ_Y on the overall performance of the Shewhart-RZ control chart in the presence of measurement error for $\eta_X = \eta_Y = 0$, $\rho_M = 0$, $n \in \{1, 15\}$, $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$, and $\rho_0 \neq \rho_1$.

Figure 6: The effect of ρ_M on the overall performance of the Shewhart-RZ control chart in the presence of measurement error for $n = 1$ ($-\square-$) and $n = 15$ ($-\blacksquare-$), $\eta_X = \eta_Y = 0.28$, $\theta_X = \theta_Y = 0.05$, $n \in \{1, 15\}$, $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$ and $\rho_0 = \rho_1 = -0.8$.

Figure 7: The effect of ρ_M on the overall performance of the Shewhart-RZ control chart in the presence of measurement error for $n = 1$ ($\square$ -) and $n = 15$ ($\blacksquare$ -), $\eta_X = \eta_Y = 0.28$, $\theta_X = \theta_Y = 0.05$, $n \in \{1, 15\}$, $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$ and $\rho_0 = -0.4, \rho_1 = -0.8$.

Figure 8: The effect of m on the overall performance of the Shewhart-RZ control chart in the presence of measurement error for $n = 1$ ($-\square-$) and $n = 15$ ($-\blacksquare-$), $\eta_X = \eta_Y = 0.28$, $\theta_X = \theta_Y = 0.05$, $n \in \{1, 15\}$, $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$ and $\rho_0 = \rho_1 = -0.8$.

Figure 9: The effect of m on the overall performance of the Shewhart-RZ control chart in the presence of measurement error for $n = 1$ ($-\square-$) and $n = 15$ ($-\blacksquare-$), $\eta_X = \eta_Y = 0.28$, $\theta_X = \theta_Y = 0.05$, $n \in \{1, 15\}$, $\gamma_X = \gamma_Y \in \{0.01, 0.2\}$ and $\rho_0 = -0.4, \rho_1 = -0.8$.

Table 6: The battery recycling industry example data

Sample	$X_{i,j}^*$ [kg]					$\bar{X}_i^*$ [kg]	$\hat{Z}_i^* = \frac{\bar{X}_i^*}{\bar{Y}_i^*}$
	$Y_{i,j}^*$ [kg]					$\bar{Y}_i^*$ [kg]	
1	95.864	94.731	94.643	94.193	94.328	94.752	0.951
	100.891	100.143	100.340	97.740	99.295	99.682	
2	94.969	94.935	94.270	94.663	93.961	94.560	0.956
	98.903	96.883	97.329	101.021	100.278	98.883	
3	93.274	95.927	94.961	96.021	95.429	95.122	0.945
	101.525	100.461	100.826	98.936	101.398	100.629	
4	95.350	96.128	96.610	95.022	95.737	95.769	0.955
	101.137	101.127	100.052	98.796	100.115	100.245	
5	94.697	96.827	94.392	94.197	96.205	95.264	0.955
	98.996	100.356	99.860	100.082	99.377	99.734	
6	94.623	93.930	96.532	94.197	93.573	94.571	0.953
	99.309	99.727	98.908	98.534	99.745	99.245	
7	94.419	95.445	94.328	95.120	95.880	95.038	0.946
	99.936	99.836	101.138	99.668	101.850	100.486	
8	96.144	94.121	96.163	93.803	94.900	95.026	0.953
	98.212	100.667	99.683	99.044	101.184	99.758	
9	94.151	94.786	95.127	94.098	94.307	94.494	0.948
	99.173	100.873	100.487	100.635	98.675	99.969	
10	96.006	96.319	94.026	94.660	93.948	94.992	0.949
	99.392	98.783	100.008	101.235	101.325	100.149	
11	93.436	94.988	93.583	94.831	92.875	93.9426	0.934
	100.491	100.976	100.815	100.102	100.685	100.614	
12	95.832	95.250	94.402	95.221	95.698	95.281	0.947
	100.007	101.654	100.648	101.531	99.040	100.576	
13	95.746	93.764	92.958	94.811	94.250	94.306	0.943
	99.164	100.864	100.174	99.642	100.309	100.031	
14	95.897	95.408	95.121	94.810	96.402	95.528	0.956
	101.025	98.955	100.267	99.332	100.238	99.963	
15	95.481	95.595	94.547	95.299	94.600	95.104	0.944
	99.933	99.406	102.736	100.533	101.300	100.782

Figure 10: The Shewhart-RZ⁻ control chart in the presence of measurement error for the battery recycling industry dataset

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